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TRF370417

SLWS213A - JANUARY 2010 - REVISED NOVEMBER 2015

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TRF370417 50-MHz to 6-GHz Quadrature Modulator

Technical

Documents

1 Features

- 76-dBc Single-Carrier WCDMA ACPR at -8 dBm Channel Power
- Low Noise Floor: -162.3 dBm/Hz at 2140 MHz
- OIP3 of 26.5 dBm at 2140 MHz
- P1dB of 12 dBm at 2140 MHz
- Carrier Feedthrough of -38 dBm at 2140 MHz
- Side-Band Suppression of -50 dBc at 2140 MHz
- Single Supply: 4.5-V-5.5-V Operation
- Silicon Germanium Technology
- 1.7-V CM at I, Q Baseband Inputs

Applications 2

- Cellular Base Station Transceiver •
- CDMA: IS95, UMTS, CDMA2000, TD-SCDMA
- TDMA: GSM, IS-136, EDGE/UWC-136
- Multicarrier GSM
- WiMAX: 802.16d/e
- 3GPP: LTE
- Point-to-Point (P2P) Microwave
- Wideband Software-Defined Radio
- Public Safety: TETRA/APC025
- **Communication-System Testers**
- Cable Modem Termination System (CMTS)

3 Description

Tools &

Software

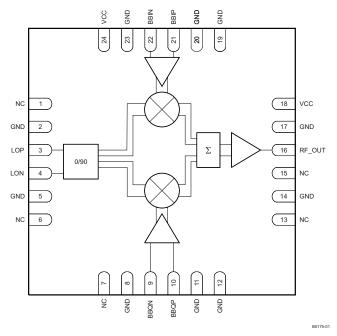
The TRF370417 is a low-noise direct quadrature modulator, capable of converting complex modulated signals from baseband or IF directly up to RF. The TRF370417 is a high-performance, superior-linearity device that operates at RF frequencies of 50 MHz through 6 GHz. The modulator is implemented as a double-balanced mixer. The RF output block consists of a differential to single-ended converter and an RF amplifier capable of driving a single-ended 50- Ω load without any need of external components. The TRF370417 requires a 1.7-V common-mode voltage for optimum linearity performance.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
TRF370417	VQFN(24)	4.00 mm × 4.00 mm		

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Block Diagram





Page

STRUMENTS

EXAS

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4 Revision History

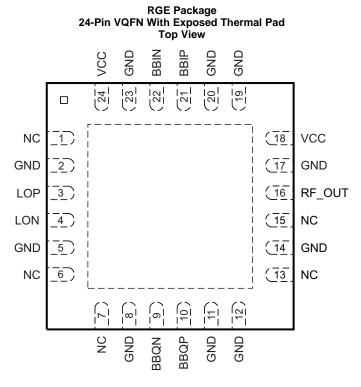
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Original (January 2010) to Revision A

Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation	
section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and	
Mechanical, Packaging, and Orderable Information section.	1



5 Pin Configuration and Functions



Pin Functions

P	IN	I/O	DESCRIPTION
NAME	NO.	1/0	DESCRIPTION
BBIN	22	I	In-phase negative input
BBIP	21	I	In-phase positive input
BBQN	9	I	Quadrature-phase negative input
BBQP	10	I	Quadrature-phase positive input
GND	2, 5, 8, 11, 12, 14, 17, 19, 20, 23	_	Ground
LON	4	I	Local oscillator (LO) negative input
LOP	3	I	Local oscillator (LO) positive input
NC	1, 6, 7, 13, 15	—	No connect
RF_OUT	16	0	RF output
VCC	18, 24		Power supply

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6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

		MIN	MAX	UNIT
	Supply voltage range	-0.3	6	V
T_{J}	Operating virtual junction temperature range	-40	150	°C
T _A	Operating ambient temperature range	-40	85	°C
T _{stg}	Storage temperature range	-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±75	
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 $^{(2)}$	±75	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
V _{CC}	Power-supply voltage	4.5	5	5.5	V

6.4 Thermal Information

		TRF370417	
	THERMAL METRIC ⁽¹⁾	RGE (VQFN)	UNIT
		24 PINS	
R _{θJA}	Junction-to-ambient thermal resistance (High-K board, still air)	29.4	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	18.6	°C/W
R _{θJB}	Junction-to-board thermal resistance	14	°C/W
Ψ _{JT}	Junction-to-top characterization parameter	_	°C/W
Ψ _{JB}	Junction-to-board characterization parameter	_	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	_	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.



6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
DC Para	ameters					
I _{CC}	Total supply current (1.7 V CM)	$T_A = 25^{\circ}C$		205	245	mA
LO Inpu	ut (50-Ω, Single-Ended)	·				
	LO frequency range		0.05		6	GHz
f _{LO}	LO input power		-5	0	12	dBm
	LO port return loss			15		dB
Baseba	and Inputs					
V_{CM}	I and Q input dc common voltage			1.7		
BW	1-dB input frequency bandwidth			1		GHz
-	Input impedance, resistance			5		kΩ
Z _{I(single} ended)	Input impedance, parallel capacitance			3		pF

6.6 **RF Output Parameters**

over recommended operating conditions, power supply = 5 V, $T_A = 25^{\circ}C$, $V_{CM} = 1.7$ V, $V_{inBB} = 98$ mVrms single-ended in quadrature, $f_{BB} = 50$ kHz (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN TYP MAX	K UNIT
f _{LO} = 7	0 MHz at 8 dBm	•		
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-8	dB
P1dB	Output compression point		7.3	dBm
IP3	Output IP3	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$	22	dBm
IP2	Output IP2	f_{BB} = 4.5, 5.5 MHz; P_{out} = -8 dBm per tone	69	dBm
	Carrier feedthrough	Unadjusted	-46	dBm
	Sideband suppression	Unadjusted; f _{BB} = 4.5, 5.5 MHz	-27.5	dBc
$f_{LO} = 4$	00 MHz at 8 dBm			
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-1.9	dB
P1dB	Output compression point		11	dBm
IP3	Output IP3	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$	24.5	dBm
IP2	Output IP2	f_{BB} = 4.5, 5.5 MHz; P_{out} = -8 dBm per tone	68	dBm
	Carrier feedthrough	Unadjusted	-38	dBm
	Sideband suppression	Unadjusted; f _{BB} = 4.5, 5.5 MHz	-40	dBc
f _{LO} = 9	45.6 MHz at 8 dBm			
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-2.5	dB
P1dB	Output compression point		11	dBm
IP3	Output IP3	f_{BB} = 4.5, 5.5 MHz; P_{out} = -8 dBm per tone	25	dBm
IP2	Output IP2	f_{BB} = 4.5, 5.5 MHz; P_{out} = -8 dBm per tone	65	dBm
	Carrier feedthrough	Unadjusted	-40	dBm
	Sideband suppression	Unadjusted; f _{BB} = 4.5, 5.5 MHz	-42	dBc
	Output return loss		9	dB
	Output noise floor	≥13 MHz offset from f _{LO} ; P _{out} = −5 dBm	-161.2	dBm/Hz
f _{LO} = 1	800 MHz at 8 dBm			
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-2.5	dB
P1dB	Output compression point		12	dBm
IP3	Output IP3	f_{BB} = 4.5, 5.5 MHz; P_{out} = -8 dBm per tone	26	dBm
IP2	Output IP2	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$	60	dBm
	Carrier feedthrough	Unadjusted	-40	dBm
	Sideband suppression	Unadjusted; f _{BB} = 4.5, 5.5 MHz	-50	dBc

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RF Output Parameters (continued)

over recommended operating conditions, power supply = 5 V, T_A = 25°C, V_{CM} = 1.7 V, V_{inBB} = 98 mVrms single-ended in quadrature, $f_{BB} = 50$ kHz (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT	
	Output return loss			8		dB	
	Output noise floor	≥13 MHz offset from f _{LO} ; P _{out} = −5 dBm	_	-161.5		dBm/Hz	
f _{LO} = 19	960 MHz at 8 dBm	· · · · · ·					
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage		-2.5		dB	
P1dB	Output compression point			12		dBm	
IP3	Output IP3	f_{BB} = 4.5, 5.5 MHz; P_{out} = -8 dBm per tone		26.5		dBm	
IP2	Output IP2	f_{BB} = 4.5, 5.5 MHz; P_{out} = -8 dBm per tone		60		dBm	
	Carrier feedthrough	Unadjusted		-38		dBm	
	Sideband suppression	Unadjusted; f _{BB} = 4.5, 5.5 MHz		-50		dBc	
	Output return loss			8		dB	
	Output noise floor	≥13 MHz offset from f _{LO} ; P _{out} = −5 dBm		-162		dBm/Hz	
EVM	Error vector magnitude (rms)	1 EDGE signal, P _{out} = -5 dBm ⁽¹⁾		0.43%			
	Adjacent-channel power ratio	1 WCDMA signal; P _{out} = -8 dBm ⁽²⁾		-76		dBc	
		1 WCDMA signal; P _{out} = -8 dBm ⁽³⁾		-74			
ACPR		2 WCDMA signals; P _{out} = -11 dBm per carrier ⁽³⁾		-68			
		4 WCDMA signals; $P_{out} = -14 \text{ dBm per carrier}^{(3)}$		-67			
	Alternate-channel power ratio	1 WCDMA signal; P _{out} = -8 dBm ⁽²⁾		-80		dBc	
		1 WCDMA signal; $P_{out} = -8 \text{ dBm}^{(3)}$		-78			
		2 WCDMA signals; $P_{out} = -11 \text{ dBm per carrier}^{(3)}$		-72			
		4 WCDMA signals; $P_{out} = -14 \text{ dBm per carrier}^{(3)}$		-69			
f _{LO} = 2 [.]	140 MHz at 8 dBm	· · · · · · · · · · · · · · · · · · ·					
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage		-2.4		dB	
P1dB	Output compression point			12		dBm	
IP3	Output IP3	f_{BB} = 4.5, 5.5 MHz; P_{out} = -8 dBm per tone		26.5		dBm	
IP2	Output IP2	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$		66		dBm	
	Carrier feedthrough	Unadjusted		-38		dBm	
	Sideband suppression	Unadjusted; f _{BB} = 4.5, 5.5 MHz		-50		dBc	
	Output return loss			8.5		dB	
	Output noise floor	≥13 MHz offset from f _{LO} ; P _{out} = -5 dBm	_	-162.3		dBm/Hz	
		1 WCDMA signal; P _{out} = -8 dBm ⁽²⁾		-76			
		1 WCDMA signal; P _{out} = -8 dBm ⁽³⁾		-72		dBc	
	Adjacent-channel power ratio	2 WCDMA signal; $P_{out} = -11 \text{ dBm per carrier}^{(3)}$		-67			
		4 WCDMA signals; $P_{out} = -14 \text{ dBm per carrier}^{(3)}$		-66			
ACPR		1 WCDMA signal; $P_{out} = -8 \text{ dBm}^{(2)}$		-80			
	Allowed a shew that the	1 WCDMA signal; $P_{out} = -8 \text{ dBm}^{(3)}$		-78		10	
	Alternate-channel power ratio	2 WCDMA signal; $P_{out} = -11 \text{ dBm}^{(3)}$		-74		dBc	
		4 WCDMA signals; $P_{out} = -14$ dBm per carrier ⁽³⁾		-68			

The contribution from the source of about 0.28% is not de-embedded from the measurement. (1)

(2)

Measured with DAC5687 as source generator; with 2.5 MHz LPF. Measured with DAC5687 as source generator; no external BB filters are used. (3)

RF Output Parameters (continued)

over recommended operating conditions, power supply = 5 V, $T_A = 25^{\circ}C$, $V_{CM} = 1.7$ V, $V_{inBB} = 98$ mVrms single-ended in quadrature, $f_{BB} = 50$ kHz (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT	
f _{LO} = 2	500 MHz at 8 dBm					
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-1.6		dB	
P1dB	Output compression point		13		dBm	
IP3	Output IP3	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$ 29				
IP2	Output IP2	$f_{BB} = 4.5, 5.5 \text{ MHz}; P_{out} = -8 \text{ dBm per tone}$	65		dBm	
	Carrier feedthrough	Unadjusted	-37		dBm	
	Sideband suppression	Unadjusted; f _{BB} = 4.5, 5.5 MHz	-47		dBc	
		WiMAX 5-MHz carrier, $P_{out} = -8 \text{ dBm}^{(4)}$	-47		dB	
EVM	Error vector magnitude (rms)	WiMAX 5-MHz carrier, $P_{out} = 0 \text{ dBm}^{(4)}$	-45		dB	
f _{LO} = 3	500 MHz at 8 dBm					
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	0.6		dB	
P1dB	Output compression point		13.5		dBm	
IP3	Output IP3	f _{BB} = 4.5, 5.5 MHz	25		dBm	
IP2	Output IP2	f _{BB} = 4.5, 5.5 MHz	65		dBm	
	Carrier feedthrough	Unadjusted	-35		dBm	
	Sideband suppression	Unadjusted; f _{BB} = 4.5, 5.5 MHz	-36		dBc	
-		WiMAX 5-MHz carrier, $P_{out} = -8 \text{ dBm}^{(4)}$	-47		dB	
EVM	Error vector magnitude (rms)	WiMAX 5-MHz carrier, $P_{out} = 0 \text{ dBm}^{(4)}$	-43		dB	
$f_{LO} = 4$	000 MHz at 8 dBm					
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	0.2		dB	
P1dB	Output compression point		12		dBm	
IP3	Output IP3	f _{BB} = 4.5, 5.5 MHz	22.5		dBm	
IP2	Output IP2	f _{BB} = 4.5, 5.5 MHz	60		dBm	
	Carrier feedthrough	Unadjusted	-36		dBm	
	Sideband suppression	Unadjusted; f _{BB} = 4.5, 5.5 MHz	-36		dBc	
f _{LO} = 5	800 MHz at 4 dBm					
G	Voltage gain	Output rms voltage over input I (or Q) rms voltage	-5.5		dB	
P1dB	Output compression point		12.9		dBm	
IP3	Output IP3	f _{BB} = 4.5, 5.5 MHz	25		dBm	
IP2	Output IP2	f _{BB} = 4.5, 5.5 MHz	55		dBm	
	Carrier feedthrough	Unadjusted	-31		dBm	
	Sideband suppression	Unadjusted; f _{BB} = 4.5, 5.5 MHz	-36		dBc	
EVM	Error-vector magnitude	WiMAX 5-MHz carrier, $P_{out} = -12 \text{ dBm}^{(4)}$	-40		dB	

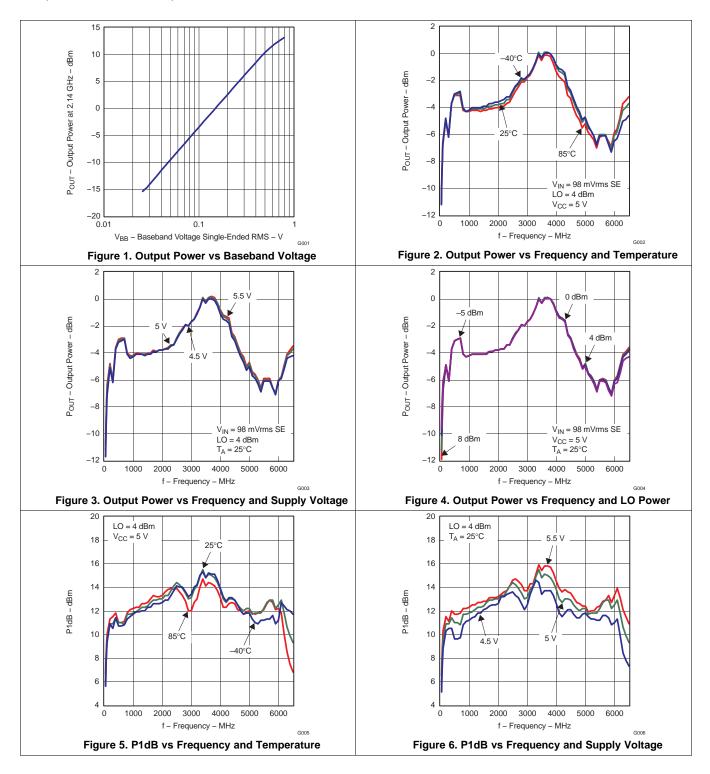
(4) Sideband suppression optimized with LO drive level; EVM contribution from instrument is not accounted for.

TRF370417

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6.7 Typical Characteristics

 V_{CM} = 1.7 V, V_{inBB} = 98 mVrms single-ended sine wave in quadrature, V_{CC} = 5 V, LO power = 4 dBm (single-ended), f_{BB} = 50 kHz (unless otherwise noted).



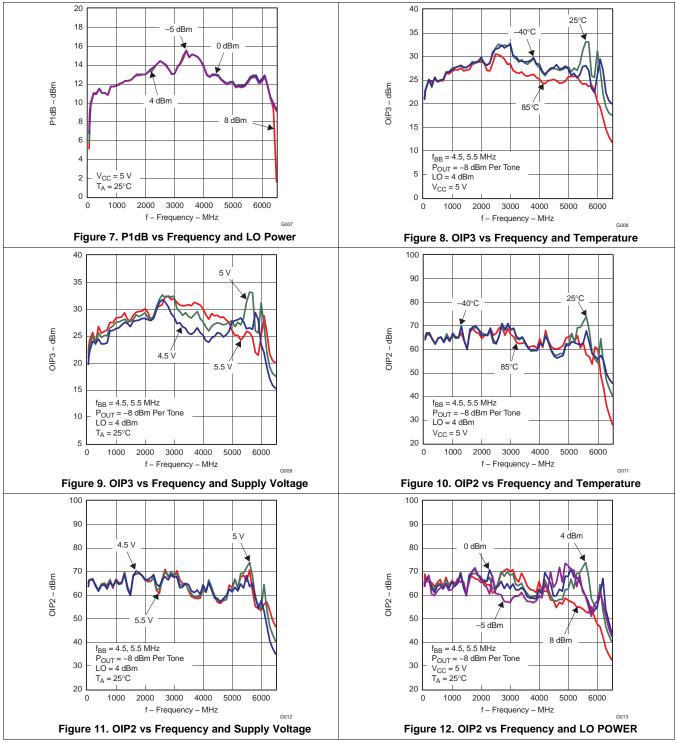
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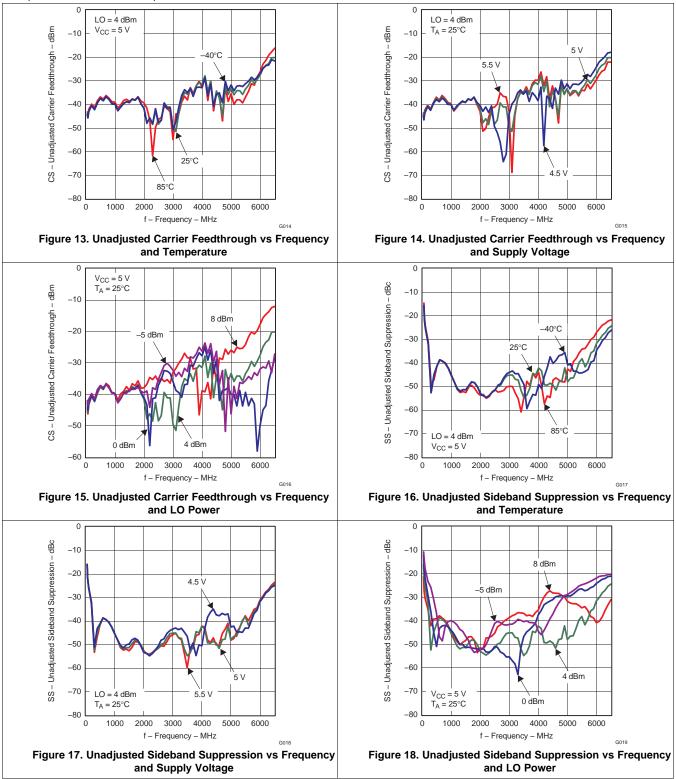
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Typical Characteristics (continued)

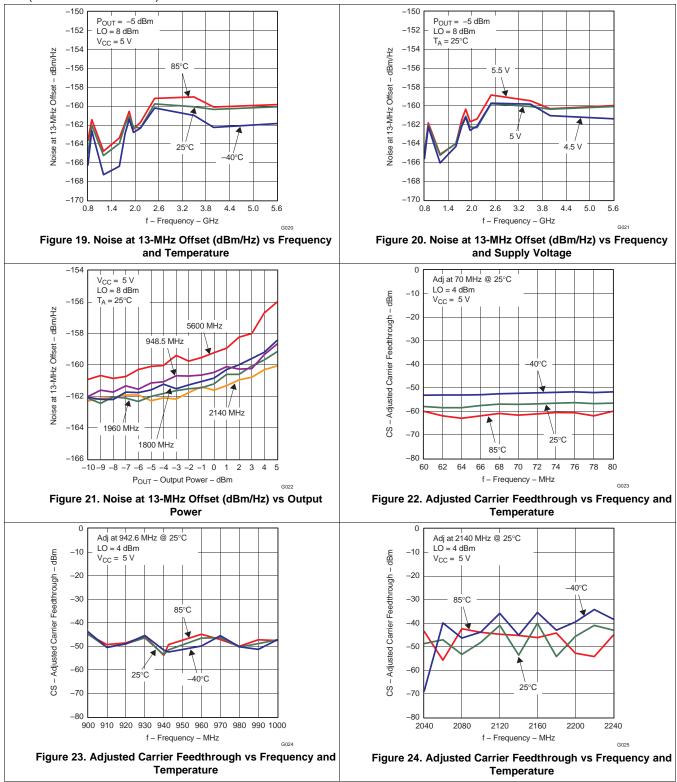


Typical Characteristics (continued)





Typical Characteristics (continued)



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Typical Characteristics (continued)

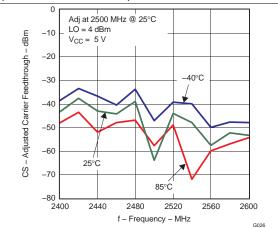


Figure 25. Adjusted Carrier Feedthrough vs Frequency and Temperature

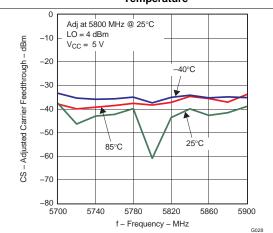
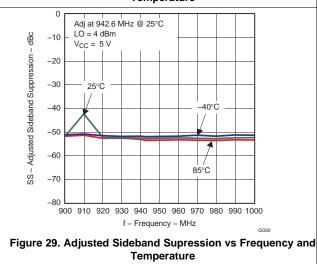


Figure 27. Adjusted Carrier Feedthrough vs Frequency and Temperature



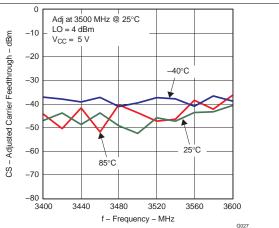


Figure 26. Adjusted Carrier Feedthrough vs Frequency and Temperature

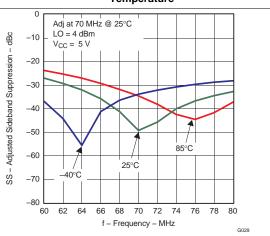
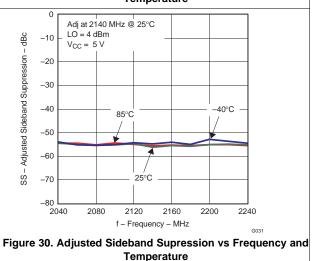


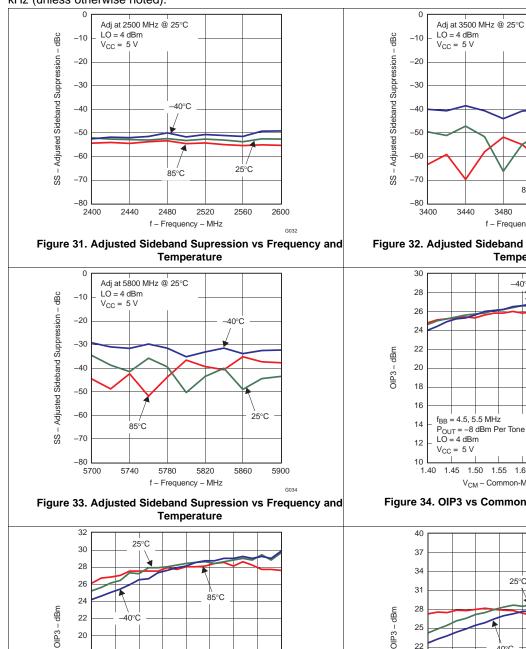
Figure 28. Adjusted Sideband Supression vs Frequency and Temperature





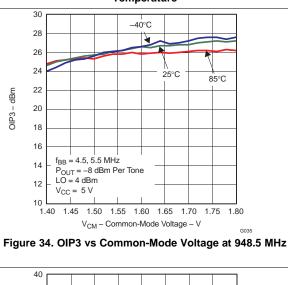
Typical Characteristics (continued)

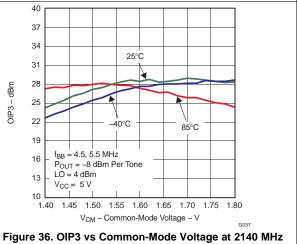
V_{CM} = 1.7 V, V_{inBB} = 98 mVrms single-ended sine wave in quadrature, V_{CC} = 5 V, LO power = 4 dBm (single-ended), f_{BB} = 50 kHz (unless otherwise noted).



-40°C 85°C 25°C 3480 3520 3560 3600 f - Frequency - MHz G033

Figure 32. Adjusted Sideband Supression vs Frequency and Temperature





f_{BB} = 4.5, 5.5 MHz

LO = 4 dBm

 $V_{CC} = 5 V$

P_{OUT} = -8 dBm Per Tone

1.40 1.45 1.50 1.55 1.60 1.65 1.70 1.75 1.80

 V_{CM} – Common-Mode Voltage – V

Figure 35. OIP3 vs Common-Mode Voltage at 1800 MHz

18

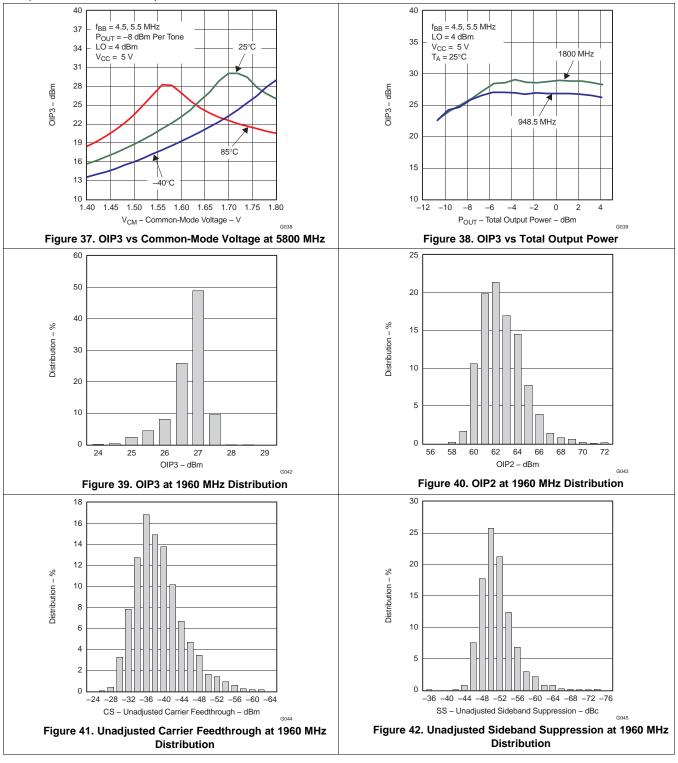
16

14

12

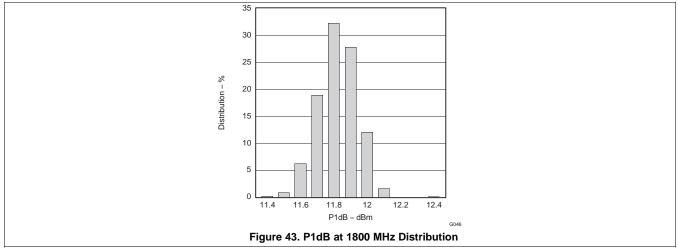
10

Typical Characteristics (continued)





Typical Characteristics (continued)



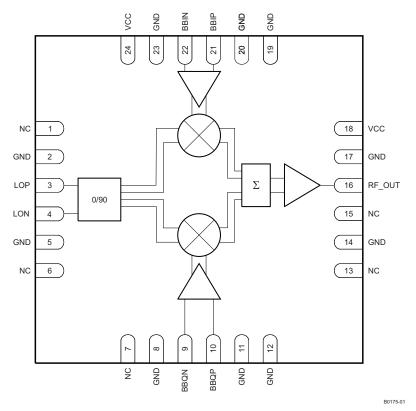


7 Detailed Description

7.1 Overview

TRF370417 is a low-noise direct quadrature modulator with high linearity, capable of converting complex modulated signals from baseband or IF directly to RF. With high-performance and superior-linearity, the TRF370417 is an ideal device to up-convert to RF frequencies from 50-MHz through 6-GHz. The baseband inputs can support an input bandwidth up to 1-GHz. The modulator is implemented as a double-balanced mixer. The RF output block contains a differential to single-ended converter to drive a 50-ohm load without the need for external matching components. The baseband input common-mode voltage is set at 1.7-V for optimum linearity performance.

7.2 Functional Block Diagram



NOTE: NC = No connection

7.3 Feature Description

TRF370417 supports an I/Q baseband input bandwidth of 1-GHz. With this bandwidth capability the input signal can be centered at a high IF frequency to provide frequency separation from unwanted carrier feed-through or sideband image. Utilizing the full baseband bandwidth yields an RF output bandwidth up to 2-GHz.

7.4 Device Functional Modes

7.4.1 Baseband Common-Mode Voltage

TRF370417 input baseband pins operate around a common-mode voltage of 1.7-V. Variation around this common-mode is possible but best linearity performance is generally achieved when kept at nominal voltage.



Device Functional Modes (continued)

7.4.2 LO Drive Level

The LO drive level is nominally specified at 4-dBm. The device can accept a large range of LO drive level. A higher drive level generally provides better output noise performance and some linearity improvement. There is some trade-off between carrier feed-through and sideband suppression performance that is dependent on frequency and drive level. The LO drive level of 4-dB is deemed a good balance between those two parameters across frequency.

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8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

8.1.1 Basic Connections

- See Figure 44 for proper connection of the TRF3704 modulator.
- Connect a single power supply (4.5 V–5.5 V) to pins 18 and 24. These pins should be decoupled as shown on pins 4, 5, 6, and 7.
- Connect pins 2, 5, 8, 11, 12, 14, 17, 19, 20, and 23 to GND.
- Connect a single-ended LO source of desired frequency to LOP (amplitude between -5 dBm and 12 dBm). This should be ac-coupled through a 100-pF capacitor.
- Terminate the ac-coupled LON with 50 Ω to GND.
- Connect a baseband signal to pins 21 = I, $22 = \overline{I}$, 10 = Q, and $9 = \overline{Q}$.
- The differential baseband inputs should be set to the proper common-mode voltage of 1.7 V.
- RF_OUT, pin 16, can be fed to a spectrum analyzer set to the desired frequency, LO ± baseband signal. This pin should also be ac-coupled through a 100-pF capacitor.
- All NC pins can be left floating.

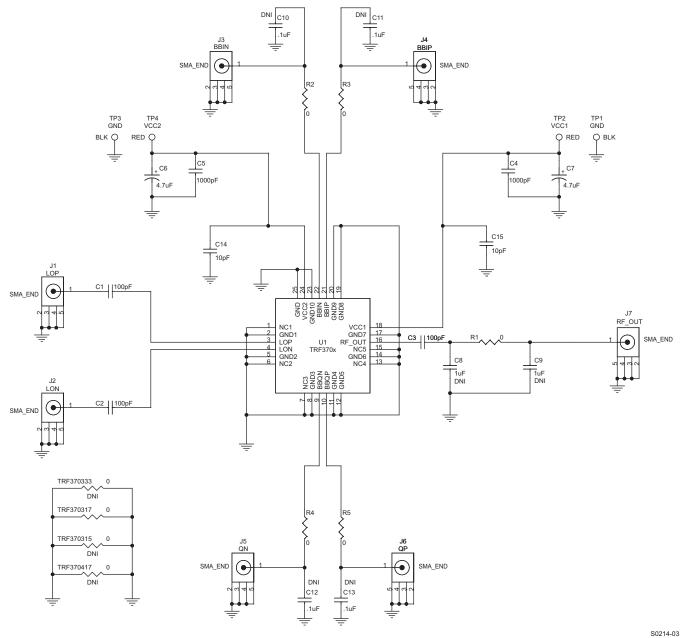
8.1.1.1 ESD Sensitivity

RF devices may be extremely sensitive to electrostatic discharge (ESD). To prevent damage from ESD, devices should be stored and handled in a way that prevents the build-up of electrostatic voltages that exceed the rated level. Rated ESD levels should also not be exceeded while the device is installed on a printed circuit board (PCB). Follow these guidelines for optimal ESD protection:

- Low ESD performance is not uncommon in RF ICs; see the *Absolute Maximum Ratings* table. Therefore, customers' ESD precautions should be consistent with these ratings.
- The device should be robust once assembled onto the PCB *unless* external inputs (connectors, etc.) directly connect the device pins to off-board circuits.



Application Information (continued)



NOTE: DNI = Do not install.





8.1.2 GSM Applications

The TRF370417 is suited for GSM and multicarrier GSM applications because of its high linearity and low noise level over the entire recommended operating range. It also has excellent EVM performance, which makes it ideal for the stringent GSM/EDGE applications.

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Application Information (continued)

8.1.3 WCDMA Applications

The TRF370417 is also optimized for WCDMA applications where both adjacent-channel power ratio (ACPR) and noise density are critically important. Using Texas instruments' DAC568X series of high-performance digital-to-analog converters as depicted in Figure 44, excellent ACPR levels were measured with one-, two-, and four-WCDMA carriers. See *Electrical Characteristics*, $f_{LO} = 1960$ MHz and $f_{LO} = 2140$ MHz for exact ACPR values.

8.2 Typical Application

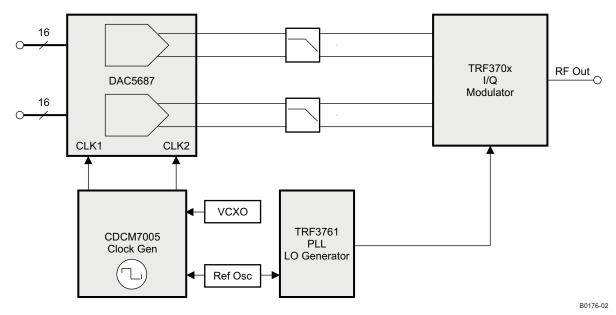


Figure 45. Typical Transmit Setup Block Diagram

8.2.1 Design Requirements

Table 1 lists the requirements and limitations for pin termination.

NAME	PIN NO.	DESCRIPTION
BBQM	9	Baseband in-quadrature input: negative terminal. Optimal linearity is obtained if VCM is 1.7-V. Normally terminated in 50 Ω
BBQP	10	Baseband in-quadrature input: positive terminal. Optimal linearity is obtained if VCM is 1.7-V. Normally terminated in 50 Ω
BBIP	21	Baseband in-phase input: positive terminal. Optimal linearity is obtained if VCM is 1.7-V. Normally terminated in 50 Ω
BBIM	22	Baseband in-phase input: negative terminal. Optimal linearity is obtained if VCM is 1.7-V. Normally terminated in 50 Ω
LOP	3	Local oscillator input: positive terminal. This is preferred port when driving single ended. Normally AC coupled and terminated in 50 Ω
LOM	4	Local oscillator input: negative terminal. When driving LO single-ended, normally AC coupled and terminated in 50 Ω .
RFOUT	16	RF output. Normally AC coupled. Recommend to terminate with broadband 50- Ω load.
VCC	18, 24	5.0-V power supply. Can be tied together and sourced from a single clean supply. Each pin should be properly RF bypassed.

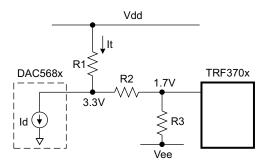
8.2.2 Detailed Design Procedure

ITEM NUMBER	QUANTITY	REFERENCE DESIGNATOR	VALUE	PCB FOOTPRINT	MFR. NAME	MFT. PART NUMBER	NOTE
1	3	C1, C2, C3	100 pF	0402	PANASONIC	ECJ-0EC1H101J	
2	2	C4, C5	1000 pF	0402	PANASONIC	ECJ-0VC1H102J	
3	2	C6, C7	4.7 μF	TANT_A	KERMET	T491A475K016AS	
4	0	C8, C9	1 µF	0402	PANASONIC	ECJ- 0EC1H010C_DNI	DNI
5	0	C10, C11, C12, C13	0.1 µF	0402	0402 PANASONIC ECJ- 0EB1A104K_DNI		DNI
6	2	C14, C15	10 pF	0402 MURATA		GRM1555C1H100JZ0 1D	
7	7	J1, J2, J3, J4, J5, J6, J7	LOP	SMA_SMEL_250x215	JOHNSON COMPONENTS	142-0711-821	
8	2	R1	0	0402	PANASONIC	ERJ-2GE0R00	OR EQUIVALENT
9	4	R2, R3, R4, R5	0	0402	PANASONIC	ERJ-2GE0R00	OR EQUIVALENT
			TRF370333	QFN_24_163x163_ 0p50mm	ті	TRF370333	For TRF370333 EVM, TI supplied
10			TRF370317	QFN_24_163x163_ 0p50mm	ті	TRF370317	For TRF370317 EVM, TI supplied
10	1	U1	TRF370315	QFN_24_163x163_ 0p50mm	ті	TRF370315	For TRF370315 EVM, TI supplied
			TRF370417	QFN_24_163x163_ 0p50mm	ті	TRF370417	For TRF370417 EVM, TI supplied
11	2	TP1, TP3	BLK	TP_THVT_100_RND	KEYSTONE	5001K	
12	2	TP2, TP4	RED	TP_THVT_100_RND	KEYSTONE	5000K	

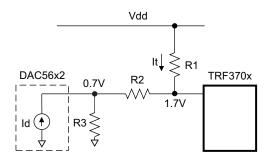
Table 2. Bill of Materials for TRF370x EVM

8.2.2.1 DAC-to-Modulator Interface Network

For optimum linearity and dynamic range, the digital-to-analog converter (DAC) can interface directly with the modulator; however, the common-mode voltage of each device must be maintained. A passive interface circuit is used to transform the common-mode voltage of the DAC to the desired set-point of the modulator. The passive circuit invariably introduces some insertion loss between the two devices. In general, it is desirable to keep the insertion loss as low as possible to achieve the best dynamic range. Figure 46 shows the passive interconnect circuit for two different topologies. One topology is used when the DAC (such as the DAC568x) common-mode is larger than the modulator. The voltage V_{ee} is nominally set to ground, but can be set to a negative voltage to reduce the insertion loss of the network. The second topology is used when the DAC (such as the DAC56x2) common-mode is smaller than the modulator. Note that this passive interconnect circuit is duplicated for each of the differential I/Q branches.



Topology 1: DAC Vcm > TRF370x Vcm



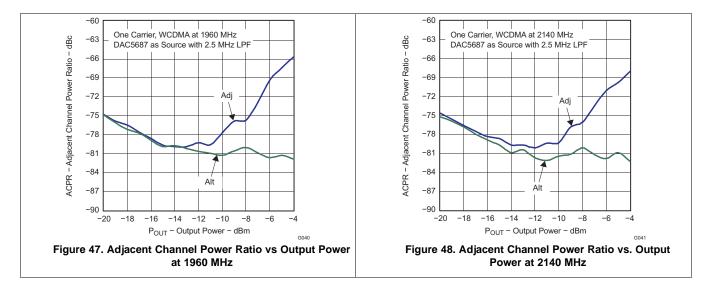
Topology 2: DAC Vcm < TRF370x Vcm

Figure 46. Passive DAC-to-Modulator Interface Network

	TOPC	DLOGY 1			
	WITH VEE = 0 V	WITH VEE = 5 V	TOPOLOGY 2		
DAC Vcm [V]	3.3	3.3	0.7		
TRF370x Vcm [V]	1.7	1.7	1.7		
Vdd [V]	5	5	5		
Vee [V]	Gnd	-5	N/A		
R1 [Ω]	66	56	960		
R2 [Ω]	100	80	290		
R3 [Ω]	108	336	52		
Insertion loss [dB]	5.8	1.9	2.3		



8.2.3 Application Curves



9 Power Supply Recommendations

The TRF370417 is powered by supplying a nominal 5 V to pins 18 and 24. These supplies can be tied together and sourced from a single clean supply. Proper RF bypassing should be placed close to each power supply pin. Ground pin connections should have at least one ground via close to each ground pin to minimize ground inductance. The thermal pad must be tied to ground, preferably with the recommended ground via pattern to provide a good thermal conduction path to the alternate side of the board and to provide a good RF ground for the device. (Refer to *Layout Guidelines* for additional information.)

10 Layout

10.1 Layout Guidelines

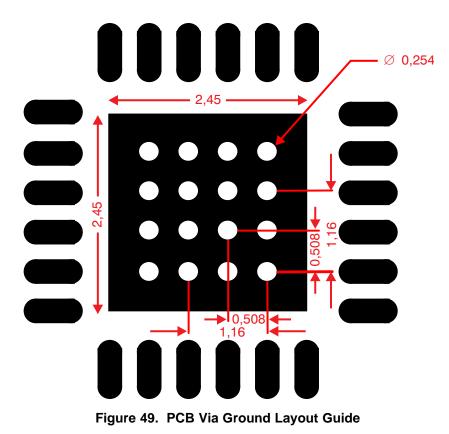
The TRF370417 device is fitted with a ground slug on the back of the package that must be soldered to the printed circuit board (PCB) ground with adequate ground vias to ensure a good thermal and electrical connection. The recommended via pattern and ground pad dimensions are shown in Figure 76. The recommended via diameter is 10 mils (0.10 in or 0.25 mm). The ground pins of the device can be directly tied to the ground slug pad for a low-inductance path to ground. Additional ground vias may be added if space allows. Decoupling capacitors at each of the supply pins are strongly recommended. The value of these capacitors should be chosen to provide a low-impedance RF path to ground at the frequency of operation. Typically, the value of these capacitors is approximately 10 pF or lower. The device exhibits symmetry with respect to the quadrature input paths. TI recommends that the PCB layout maintain this symmetry to ensure that the quadrature balance of the device is not impaired. The I/Q input traces should be routed as differential pairs and the respective lengths all kept equal to each other. On the RF traces, maintain proper trace widths to keep the characteristic impedance of the RF traces at a nominal 50 Ω .

10.2 Layout Example

Figure 49 shows the top view of the TRF3704 EVM board.

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Layout Example (continued)



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11 Device and Documentation Support

11.1 Device Support

11.1.1 Device Nomenclature

- Adjusted (Optimized) Carrier Feedthrough This differs from the unadjusted suppression number in that the baseband input dc offsets are iteratively adjusted around their theoretical value of VCM to yield the maximum suppression of the LO component in the output spectrum. This is measured in dBm.
- Adjusted (Optimized) Sideband Suppression This differs from the unadjusted sideband suppression in that the gain and phase of the baseband inputs are iteratively adjusted around their theoretical values to maximize the amount of sideband suppression. This is measured in dBc.
- **Suppressions Over Temperature** This specification assumes that the user has gone though the optimization process for the suppression in question, and set the optimal settings for the I, Q inputs. This specification then measures the suppression when temperature conditions change after the initial calibration is done.

Figure 50 shows a simulated output and illustrates the respective definitions of various terms used in this data sheet.

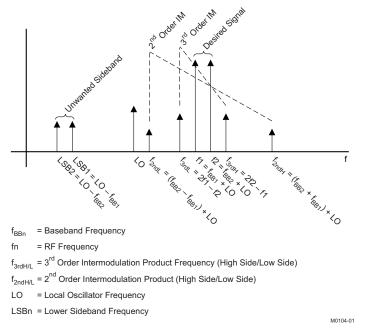


Figure 50. Graphical Illustration of Common Terms

- **Unadjusted Carrier Feedthrough** This specification measures the amount by which the local oscillator component is suppressed in the output spectrum of the modulator. If the common-mode voltage at each of the baseband inputs is exactly the same and there was no dc imbalance introduced by the modulator, the LO component would be naturally suppressed. DC offset imbalances in the device allow some of the LO component to feed through to the output. Because this phenomenon is independent of the RF output power and the injected LO input power, the parameter is expressed in absolute power, dBm.
- **Unadjusted Sideband Suppression** This specification measures the amount by which the unwanted sideband of the input signal is suppressed in the output of the modulator, relative to the wanted sideband. If the amplitude and phase within the I and Q branch of the modulator were perfectly matched, the unwanted sideband (or image) would be naturally suppressed. Amplitude and phase imbalance in the I and Q branches results in the increase of the unwanted sideband. This parameter is measured in dBc relative to the desired sideband.

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11.2 Documentation Support

11.2.1 Related Documentation

For related documentation, see the documents that follow:

- TRF370x User's Guide
- TRF370417: Optimizing OIP3 Performance at Local Oscillator (LO) Frequencies Beyond 4.5 GHz
- High Bandwidth, High Frequency Transmitter Reference Design

11.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E[™] Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support TI's Design Support Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.4 Trademarks

E2E is a trademark of Texas Instruments. All other trademarks are the property of their respective owners.

11.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

11.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



3-Nov-2015

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
TRF370417IRGER	ACTIVE	VQFN	RGE	24	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TRF37 0417	Samples
TRF370417IRGET	ACTIVE	VQFN	RGE	24	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	TRF37 0417	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

3-Nov-2015

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimen	sions are nominal												
	Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TRF3	370417IRGER	VQFN	RGE	24	3000	330.0	12.4	4.3	4.3	1.5	8.0	12.0	Q1
TRF3	370417IRGET	VQFN	RGE	24	250	330.0	12.4	4.3	4.3	1.5	8.0	12.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

1-Aug-2018



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TRF370417IRGER	VQFN	RGE	24	3000	367.0	367.0	38.0
TRF370417IRGET	VQFN	RGE	24	250	367.0	367.0	38.0

GENERIC PACKAGE VIEW

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



RGE0024B



PACKAGE OUTLINE

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



RGE0024B

EXAMPLE BOARD LAYOUT

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



RGE0024B

EXAMPLE STENCIL DESIGN

VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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